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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/726,347	CHU ET AL.	
Examiner	Art Unit	
Robert J. Hoffberg	2835	

	SEAR	CHED	
Class	Subclass	Date	Examiner
361	689, 699, 701	11/22/2005	RJH
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INT	INTERFERENCE SEARCHED			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
See attached EAST search list	11/22/2005	RJH